

Notice of References Cited	Application/Control No. 10/063,313	Applicant(s)/Patent Under Reexamination PAIK ET AL.	
	Examiner Tae H Yoon	Art Unit 1714	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,981,823	11-1999	Turngren, Christina Margaret	602/58
	B	US-2002/0098347 A1	07-2002	SZONN et al.	428/343
	C	US-6,506,447	01-2003	Hirsch et al.	427/208.4
	D	US-6,689,248	02-2004	Stahr et al.	156/324
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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